

Search Notes

Application/Control No.

10/583,920

Examiner

Shannon Janssen

Applicant(s)/Patent under
Reexamination

SAILOR ET AL.

Art Unit

1639

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
us patents and us patent applications in east - updated search	7/14/11	SLJ
inventors names in palm	7/14/11	SLJ
Pubmed, Scirus: search terms: optical, particle, code, encode, etch, and various combinations, inventor names	7/14/11	SLJ